



# 7A Ideal Diode with Reverse Input Protection

#### **FEATURES**

- Reduces Power Dissipation by Replacing a Power Schottky Diode
- Wide Operating Voltage Range: 4V to 40V
- Internal 15mΩ N-Channel MOSFET
- Reverse Input Protection to –40V
- Low 9µA Shutdown Current
- Low 150µA Operating Current
- Smooth Switchover without Oscillation
- Available in 16-Pin 5mm × 4mm DFN Package
- AEC-Q100 Qualified for Automotive Applications

#### **APPLICATIONS**

- Automotive Battery Protection
- Redundant Power Supplies
- Portable Battery Devices
- Computer Systems/Servers

#### DESCRIPTION

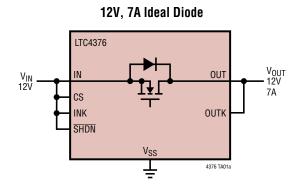
The LTC®4376 is a 7A ideal diode that uses an internal  $15m\Omega$  N-channel MOSFET to replace a Schottky diode when used in diode-OR and high current diode applications. The LTC4376 reduces power consumption, heat dissipation and PC board area.

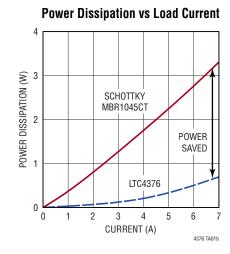
The LTC4376 controls the forward voltage drop across the internal MOSFET to ensure smooth current delivery without oscillation even at light loads. If a power source fails or is shorted, a fast turn-off minimizes reverse current transients. The LTC4376 also easily ORs power sources to increase total system reliability.

With its low operating voltage, small solution size and the ability to withstand reverse input voltage, the LTC4376 excels in portable battery applications. A shutdown mode is available to reduce the quiescent current to  $9\mu A$ . The  $\overline{SHDN}$  pin can also control the forward current path when an external MOSFET is used in series with the internal MOSFET in a back-to-back configuration.

All registered trademarks and trademarks are the property of their respective owners.

## TYPICAL APPLICATION

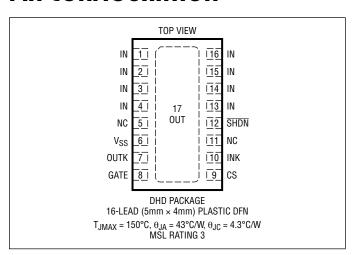




#### **ABSOLUTE MAXIMUM RATINGS**

(Notes 1, 2)	
IN, INK, CS, SHDN	40V to 80V
OUT, OUTK	0.3V to 80V
INK-OUTK	45V to 100V
INK-CS	–1V to 80V
IN-OUT (Note 3)	45V to 0.3V
GATE (Note 4)	$V_{CS} - 0.3V$ to $V_{CS} + 10V$
<b>Operating Junction Temperature</b>	e Range
LTC4376C	0°C to 70°C
LTC4376I	40°C to 85°C
LTC4376H	40°C to 125°C
Storage Temperature Range	

## PIN CONFIGURATION



## ORDER INFORMATION

TUBE	TAPE AND REEL	PART MARKING*	PACKAGE DESCRIPTION	TEMPERATURE RANGE		
LTC4376CDHD#PBF	LTC4376CDHD#TRPBF	4376	16-Lead (5mm x 4mm) Plastic DFN	0°C to 70°C		
LTC4376IDHD#PBF	LTC4376IDHD#TRPBF	4376	16-Lead (5mm x 4mm) Plastic DFN	-40°C to 85°C		
LTC4376HDHD#PBF	LTC4376HDHD#TRPBF	4376	16-Lead (5mm x 4mm) Plastic DFN	-40°C to 125°C		
AUTOMOTIVE PRODUCTS**						
LTC4376IDHD#WPBF	LTC4376IDHD#WTRPBF	4376	16-Lead (5mm x 4mm) Plastic DFN	-40°C to 85°C		
LTC4376HDHD#WPBF	LTC4376HDHD#WTRPBF	4376	16-Lead (5mm x 4mm) Plastic DFN	-40°C to 125°C		

Contact the factory for parts specified with wider operating temperature ranges. \*The temperature grade is identified by a label on the shipping container.

Tape and reel specifications. Some packages are available in 500 unit reels through designated sales channels with #TRMPBF suffix.

<sup>\*\*</sup>Versions of this part are available with controlled manufacturing to support the quality and reliability requirements of automotive applications. These models are designated with a #W suffix. Only the automotive grade products shown are available for use in automotive applications. Contact your local Analog Devices account representative for specific product ordering information and to obtain the specific Automotive Reliability reports for these models.

## **ELECTRICAL CHARACTERISTICS** The ullet denotes the specifications which apply over the full operating temperature range, otherwise specifications are at $T_A = 25 \,^{\circ}\text{C}$ . $V_{INK} = 4V$ to 40V, $V_{IN} = V_{INK}$ , unless otherwise noted.

SYMBOL	PARAMETER	AMETER CONDITIONS		MIN	TYP	MAX	UNITS
V <sub>INK</sub>	Operating Supply Range		•	4		40	V
I <sub>INK</sub>	INK Pin Current	INK = 12V INK = OUTK = 12V, <u>SHDN</u> = 0V INK = OUTK = 24V, <u>SHDN</u> = 0V INK = -40V	•	0	150 9 15 –15	250 30 40 –40	Αμ Αμ Αμ Αμ
I <sub>OUTK</sub>	OUTK Pin Current	INK = 12V, In Regulation INK = 12V, \( \Delta V \text{SD} = -1V \) INK = OUTK = 12V, \( \frac{\text{SHDN}}{\text{SHDN}} = 0V \) INK = OUTK = 24V, \( \frac{\text{SHDN}}{\text{SHDN}} = 0V \) OUTK = 12V, INK = \( \frac{\text{SHDN}}{\text{SHDN}} = 0V \)	•	3	5 120 0.8 0.8 6	7.5 220 3 3 15	Αμ Αμ Αμ Αμ
I <sub>CS</sub>	CS Pin Current	INK = 12V, $\Delta V_{SD} = -1V$ INK = CS = 12V, $\overline{SHDN}$ = 0V CS = -40V	•	1 -0.4	150 4 –0.8	200 15 –1.5	μΑ μΑ mA
I <sub>OUT</sub>	OUT Reverse Leakage Current	IN = GATE = 0V, OUT = 40V	•			150	μА
$\Delta V_{GATE}$	Gate Drive (V <sub>GATE</sub> – V <sub>CS)</sub>	INK = 4V, I <sub>GATE</sub> = 0, -1μA INK = 8V to 40V, I <sub>GATE</sub> = 0, -1μA	•	4.5 10	5.5 12	18 18	V
$\Delta V_{SD(REG)}$	Source-Drain Regulation Voltage (V <sub>INK</sub> – V <sub>OUTK</sub> )	1mA < I <sub>IN</sub> < 100mA	•	20	30	45	mV
$\Delta V_{SD(FWD)}$	Body Diode Forward Voltage Drop (V <sub>IN</sub> – V <sub>OUT</sub> )	I <sub>IN</sub> = 7A, MOSFET Off	•	0.55	0.77	1	V
R <sub>DS(ON)</sub>	Internal N-Channel MOSFET On Resistance	I <sub>IN</sub> = 7A	•		15	30	mΩ
I <sub>AS</sub>	Peak Avalanche Current	L = 0.1mH (Note 5)			40		А
I <sub>GATE(UP)</sub>	Gate Pull-Up Current	GATE = INK, $\Delta V_{SD} = 0.1V$	•	-6	-10	<b>–17</b>	μA
I <sub>GATE(DOWN)</sub>	Gate Pull-Down Current	Fault Condition, $\Delta V_{GATE} = 5V$ , $\Delta V_{SD} = -1V$ Shutdown Mode, $\Delta V_{GATE} = 5V$ , $\Delta V_{SD} = 0.7V$	•	70 0.6	130	180	mA mA
t <sub>OFF</sub>	Gate Turn-Off Delay Time	$\Delta V_{SD} = 0.1 V \text{ to } -1 V, \ \Delta V_{GATE} < 2 V$	•		0.3	0.5	μs
V <sub>SHDN(TH)</sub>	SHDN Pin Input Threshold	INK = 4V to 40V	•	0.6	1.2	2	V
V <sub>SHDN(FLT)</sub>	SHDN Pin Float Voltage	INK = 4V to 40V	•	0.6	1.75	2.5	V
I <sub>SHDN</sub>	SHDN Pin Current	<u>SHDN</u> = 0.5V <u>SHDN</u> = −40V	•	-0.5 -0.4	−3 −0.8	−5 −1.5	μA mA
I <sub>LEAK</sub>	SHDN Leakage Current	SHDN = 2.6V	•			1	μA
V <sub>CS(TH)</sub>	Reverse CS Threshold for GATE Off	GATE = 0V, I <sub>GATE(DOWN)</sub> = 1mA	•	-0.9	-1.8	-2.7	V

**Note 1:** Stresses beyond those listed underAbsolute Maximum Ratings may cause permanent damage to the device. Exposure to any Absolute Maximum Rating condition for extended periods may affect device reliability and lifetime.

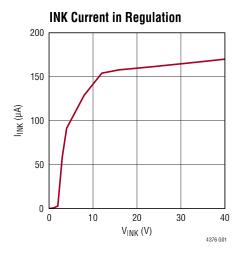
**Note 2:** All currents into pins are positive, all voltages are referenced to  $V_{SS}$  unless otherwise specified.

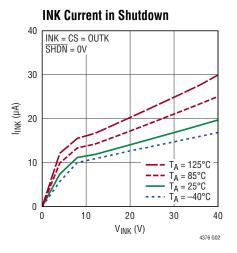
**Note 3:** This voltage is set by the MOSFET's body diode and will safely exceed 0.3V during start-up for a limited time determined by the body diode thermal dissipation.

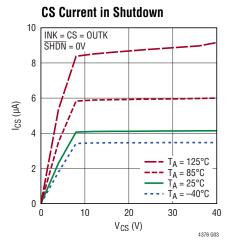
**Note 4:** An internal clamp limits the GATE pin to a minimum of 10V above CS or 90V above  $V_{SS}$ . Driving this pin to voltages beyond the clamp may damage the device.

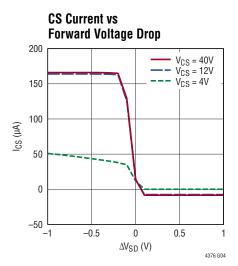
Note 5: The  $I_{\mbox{\scriptsize AS}}$  typical value is based on characterization and is not production tested.

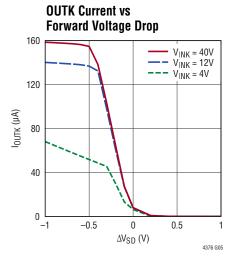
## TYPICAL PERFORMANCE CHARACTERISTICS

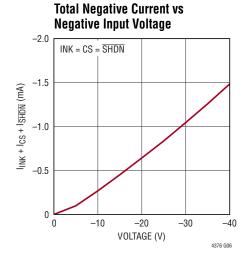






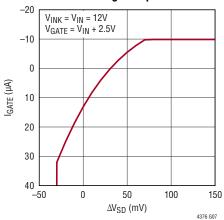




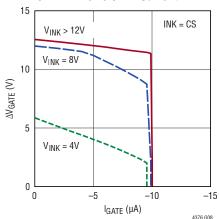


## TYPICAL PERFORMANCE CHARACTERISTICS

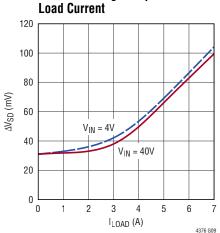
#### GATE Current vs Forward Voltage Drop



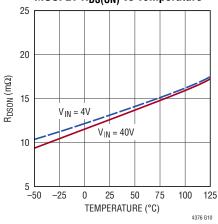
#### **GATE Drive vs GATE Current**



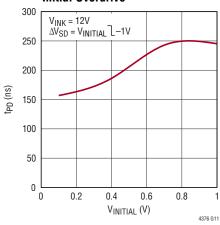
## Forward Voltage Drop vs



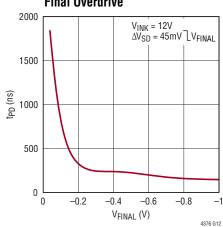
#### MOSFET R<sub>DS(ON)</sub> vs Temperature



#### FET Turn-Off Time vs Initial Overdrive



#### FET Turn-Off Time vs Final Overdrive



#### PIN FUNCTIONS

**CS:** Gate Drive Return. The fast pull-down current is returned through this pin during a reverse current event. This pin can be connected to IN or left open.

**GATE:** Gate Drive Output. The GATE pin pulls high, enhancing the N-channel MOSFET when the load current creates more than 30mV of voltage drop across the MOSFET. When the load current is small, GATE is actively driven to maintain 30mV across the MOSFET. If reverse current flows, a fast pull-down circuit quickly connects GATE to the CS pin within 300ns, turning off the MOSFET. Connect this pin to the gate of the external MOSFET in a back-to-back configuration, otherwise leave open.

**IN:** Source of Internal N-Channel MOSFET. IN is the anode of the ideal diode.

**INK:** Voltage Sense and Supply Voltage. The voltage sensed at this pin is used to control the MOSFET voltage drop. Connect this pin to IN.

**NC:** No Connection. Not internally connected.

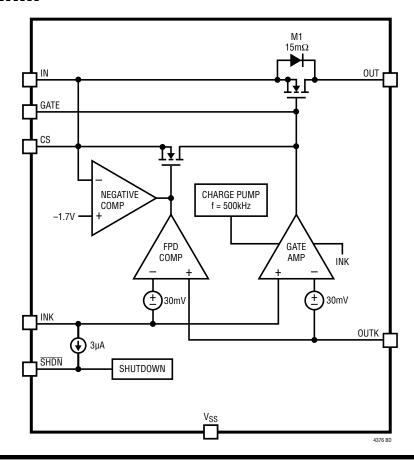
**OUT:** The exposed pad is the drain of the internal N-channel MOSFET. OUT is the cathode of the ideal diode and the common output when multiple LTC4376s are configured as an ideal diode-OR.

**OUTK:** Drain Voltage Sense. The voltage sensed at this pin is used to control the MOSFET voltage drop. Connect this pin to OUT.

SHDN: Shutdown Control Input. The LTC4376 can be shut down to a low current mode by pulling the SHDN pin below 0.6V. Pulling this pin above 2V turns the part on. The SHDN pin can be pulled up to 40V or below V<sub>SS</sub> by 40V without damage. If the shutdown feature is not used, connect SHDN to IN.

**V<sub>SS</sub>**: Device Ground.

#### **BLOCK DIAGRAM**



Rev. A

### **OPERATION**

The LTC4376 is a single positive voltage ideal diode controller that drives an internal N-channel MOSFET as a pass transistor to replace a Schottky diode. The IN and OUT pins form the anode and cathode of the ideal diode, respectively. The input supply is connected to the IN pins, while the OUT pin serves as the output. Both the INK and OUTK pins are connected directly to IN and OUT respectively.

The GATE amplifier (see Block Diagram) senses across INK and OUTK and drives the gate of the internal MOSFET to regulate the forward voltage to 30mV. As the load current increases, GATE is driven higher until a point is reached where the internal MOSFET is fully on. Further increases in load current result in a forward drop of  $R_{DS(ON)} \bullet I_{LOAD}$ .

If the load current is reduced, the GATE amplifier drives the MOSFET gate lower to maintain a 30mV drop. If the input voltage is reduced to a point where a forward drop of 30mV cannot be supported, the GATE amplifier drives the MOSFET off.

In the event of a rapid drop in input voltage, such as an input short-circuit fault or negative-going voltage spike, reverse current briefly flows through the MOSFET until it shuts off. This current is provided by any load capacitance and by other supplies or batteries that feed the output in diode-OR applications. The FPD COMP (Fast Pull-Down Comparator) quickly responds to this condition by turning the MOSFET off in 300ns, thus minimizing the disturbance to the output bus.

The IN, INK, CS, GATE and SHDN pins are protected against reverse inputs of up to -40V. The NEGATIVE COMP detects negative input potentials at the CS pin and quickly pulls GATE to CS, turning off the MOSFET and isolating the load from the negative input.

When pulled low, the  $\overline{SHDN}$  pin turns off most of the internal circuitry, reducing the quiescent current to  $9\mu A$  and holding the MOSFET off. The  $\overline{SHDN}$  pin may be either driven high or pulled up with a resistor of  $1M\Omega$  or less to enable the LTC4376. In applications where an external  $\overline{MOSFET}$  is used in series with the internal MOSFET, the  $\overline{SHDN}$  pin serves as an on/off control for the forward path, as well as enabling the diode function.

## **APPLICATIONS INFORMATION**

Blocking diodes are commonly placed in series with supply inputs for the purpose of ORing redundant power sources and protecting against supply reversal. The LTC4376 replaces diodes in these applications to reduce both the voltage drop and power loss associated with a passive solution.

The LTC4376 has a wide operating range of 4V to 40V which allows operation during cold crank conditions and transient conditions. The LTC4376 also protects against negative inputs to –40V, which can occur when the automotive battery is reversed.

A 12V/7A ideal diode application is shown in Figure 1a. Ideal diodes, like their non-ideal counterparts, exhibit a behavior known as reverse recovery. In combination with

parasitic or intentionally introduced inductances, reverse recovery spikes may be generated by an ideal diode during commutation. D1, D2 and R1 protect against these spikes which might otherwise exceed the LTC4376's –40V to 40V survival rating. If reverse input protection is not needed, Figure 1a can be simplified to Figure 1b. D1 and  $C_{OUT}$  absorb the reverse recovery energy and protect the LTC4376. Spikes and protection schemes are discussed in detail in the Input Short-Circuit Faults section.

It is important to note that the  $\overline{SHDN}$  pin, while disabling the LTC4376 and reducing its current consumption to  $9\mu A$ , does not disconnect the load from the input since the internal MOSFET's body diode is ever-present. Adding an external MOSFET permits use in load switching applications.

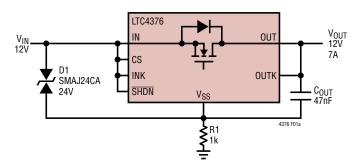


Figure 1a. 12V/7A Ideal Diode with Reverse Input Protection

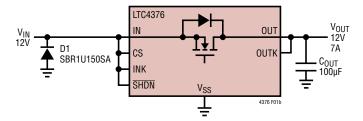


Figure 1b. 12V/7A Ideal Diode without Reverse Input Protection

#### Shutdown Mode

In shutdown, the LTC4376 pulls GATE low to CS, turning off the internal MOSFET and reducing its current consumption to 9µA. Shutdown does not interrupt forward current flow, a path is still present through the internal MOSFET's body diode. A second external MOSFET is needed to block the forward path; see the section Load Switching and Inrush Control. When enabled, the LTC4376 operates as an ideal diode. If shutdown is not needed, connect SHDN to IN. SHDN may be driven with a 3.3V or 5V logic signal or pulled up with an external resistor to IN. To enable the part, SHDN must be pulled up to at least 2V. Use a resistor value that provides more than the SHDN pin leakage current of  $1\mu A$  at 2.6V. A value of  $1M\Omega$  or less is sufficient to turn the part on. To assert SHDN low, the pull-down must sink at least 5µA plus the current provided by the external pull-up resistor at 500mV. When a high impedance pull-up resistor is used, SHDN is subject to capacitive coupling from nearby clock lines or traces exhibiting high dV/dt. Bypass SHDN to V<sub>SS</sub> with 10nF to eliminate injection. Figure 2 is the simplest way to control the shutdown pin. Since the control signal ground is different from the  $\overline{SHDN}$  pin reference,  $V_{SS},$  there could be momentary glitches on SHDN during transients. Figure 3

and Figure 4 are alternative solutions that level-shift the control signal and eliminate glitches.

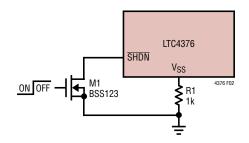


Figure 2. SHDN Control

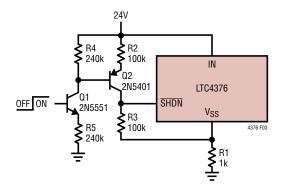


Figure 3. Transistor SHDN Control

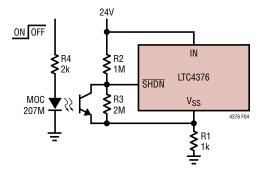


Figure 4. Opto-Isolator SHDN Control

#### **Input Short-Circuit Faults**

The dynamic behavior of an active, ideal diode entering reverse bias is most accurately characterized by a delay followed by a period of reverse recovery. During the delay phase some reverse current is built up, limited by parasitic resistances and inductances. During the reverse recovery phase, energy stored in the parasitic inductances is transferred to other elements in the circuit. Current slew rates during reverse recovery may reach 100A/µs or higher.

Rev. A

High slew rates coupled with parasitic inductances in series with the input and output paths may cause potentially destructive transients to appear at the IN, CS and OUT pins of the LTC4376 during reverse recovery. A zero impedance short-circuit directly across the input and ground is especially troublesome because it permits the highest possible reverse current to build up during the delay phase. When the internal MOSFET finally turns off to interrupt the reverse current, the LTC4376 IN and CS pins experience a negative voltage spike while the OUT pin spikes in the positive direction.

To prevent damage to the LTC4376 under conditions of input short-circuit, protect the IN, CS and OUT pins as shown in Figure 5. The IN and CS pins are protected by clamping to the V<sub>SS</sub> pin with a Tranzorb or TVS. For input voltages 24V and greater, D3 is needed to protect the internal MOSFET's gate oxide during input short-circuit conditions. Negative spikes, seen after the MOSFET turns off during an input short, are clamped by D2, a 24V TVS. D2 allows reverse inputs to 24V while keeping the MOSFET off and is not required if reverse input protection is not needed. D1 blocks D2 from conducting during normal operation. When the input short condition disappears, the current stored in the source parasitic inductance, L<sub>S</sub>, flows through the body diode of the MOSFET charging up  $C_{I,OAD}$ . If  $C_{I,OAD}$  is small or nonexistent, both the IN/ CS and OUT pins may rise to a level that can damage the LTC4376. In this case, D1 will need to be a TVS or TransZorb to limit the voltage difference between the IN/ CS and  $V_{SS}$  pins.

OUT is protected by the MOSFET's avalanche breakdown. Nevertheless, the MOSFET could be damaged by excessive current in applications greater than 24V. If the input is greater than 24V, then a 28V TVS (SMAJ28A) or a snubber can be used to protect the MOSFET and OUT pin. The snubber allows applications up to 40V (see Figure 13). Cout and R1 preserve the fast turn-off time when output parasitic inductance causes the IN and OUT voltages to drop quickly.

#### **Paralleling Supplies**

Multiple LTC4376s can be used to combine the outputs of two or more supplies for redundancy or for droop sharing, as shown in Figure 6. For redundant supplies, the supply with the highest output voltage sources most or all of the load current. If this supply's output is quickly shorted to ground while delivering load current, the flow of current temporarily reverses and flows backwards through the LTC4376's internal MOSFET. The LTC4376 senses this reverse current and activates a fast pull-down to quickly turn off the MOSFET.

If the other, initially lower supply was not delivering any load current at the time of the fault, the output falls until the body diode of its ORing internal MOSFET conducts. Meanwhile, the LTC4376 charges the internal MOSFET gate with  $10\mu A$  until the forward drop is reduced to 30mV. If this supply was sharing load current at the time of the fault, its associated ORing internal MOSFET was already driven partially on. In this case, the LTC4376 will simply

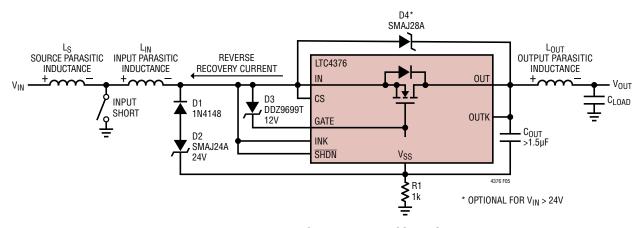


Figure 5. Reverse Recovery Produces Inductive Spikes at the IN, CS and OUT Pins. The Polarity of Step Recovery Is Shown Across Parasitic Inductances

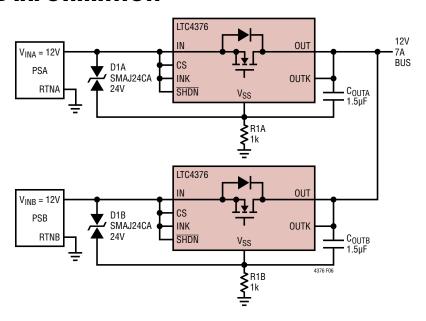


Figure 6. Redundant Power Supplies

drive the internal MOSFET gate harder in an effort to maintain a drop of 30mV.

Droop sharing can be accomplished if both power supply output voltages and output impedances are nearly equal. The 30mV regulation technique ensures smooth load sharing between outputs without oscillation. The degree of sharing is a function of internal MOSFET  $R_{DS(ON)}$ , the output impedance of the supplies and their initial output voltages.

#### **Load Switching and Inrush Control**

By adding an external MOSFET as shown in Figure 7, the LTC4376 can be used to control power flow in the forward direction while retaining ideal diode behavior in

the reverse direction. The body diodes of both the external and internal MOSFETs prohibit current flow when the MOSFETs are off. The internal MOSFET serves as the ideal diode, while the external MOSFET, M1, acts as a switch to control forward power flow. On/Off control is provided by the SHDN pin, and C1 and R3 may be added if inrush control is desired.

When  $\overline{SHDN}$  is driven high and provided  $V_{IN} > V_{OUT} + 30 \text{mV}$ , GATE sources  $10\mu\text{A}$  and gradually charges C1, pulling up both MOSFET gates. The external MOSFET operates as source follower and

$$I_{\text{INRUSH}} = \frac{10\mu\text{A} \cdot \text{C}_{\text{LOAD}}}{\text{C1}}$$

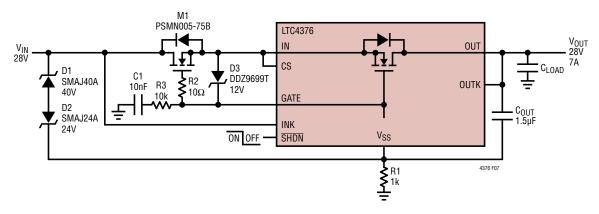


Figure 7. 28V Load Switch and Ideal Diode with Reverse Input Protection

Rev. A

If  $V_{IN}$  <  $V_{OUT}$  + 30mV, the LTC4376 will be activated but holds both the MOSFETs off until the input exceeds the output by 30mV. In this way, normal diode behavior of the circuit is preserved, but with soft starting when the diode turns on.

When SHDN is pulled low, GATE pulls both the MOSFET gates down quickly to CS turning off both forward and reverse paths, and the input current is reduced to 9µA.

While C1 and R3 may be omitted if soft starting is not needed, R2 is necessary to prevent MOSFET parasitic oscillations and must be placed close to the external MOSFET, M1.

#### **Layout Considerations**

The following advice should be considered when laying out a printed circuit board for the LTC4376: The INK and

OUTK pins should be connected as close as possible to the IN and OUT pins respectively for good accuracy. The PCB traces associated with the power path through the MOSFET should have low resistance. Keep the traces to the IN and OUT wide and short to minimize resistive losses. To ensure a low resistance contact, solder the device's OUT pin to the board using a reflow process. The wide OUT trace also acts as a heat sink to remove the heat from the device at high current load. Place  $C_{\rm OUT}$ , surge suppressors and necessary transient protection components close to the LTC4376 using short lead lengths. See Figure 8 for the recommended layout. The temperature rise of the recommended layout with 7A is 50°C.

Figure 9 through Figure 16 show typical applications of the LTC4376.

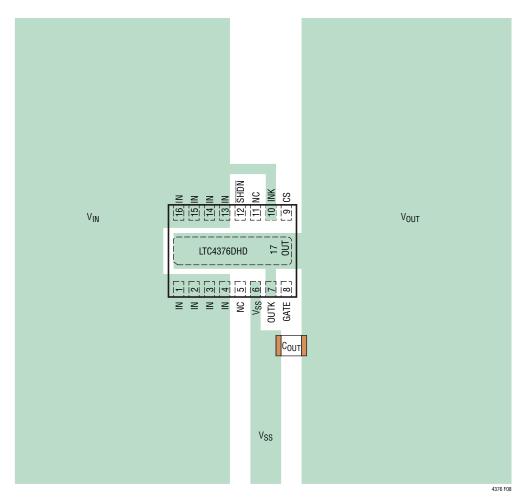


Figure 8. Recommended Layout for DFN Package

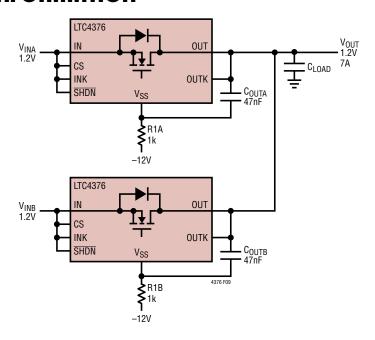


Figure 9. 1.2V Diode-OR

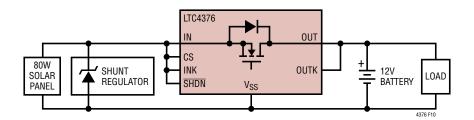


Figure 10. Lossless Solar Panel Isolation

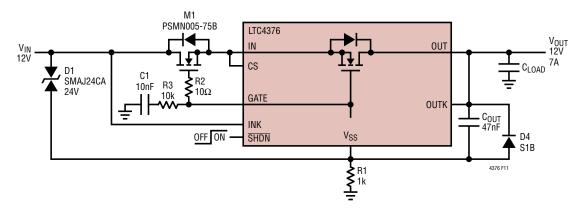


Figure 11. 12V Load Switch and Ideal Diode with Reverse Input Protection

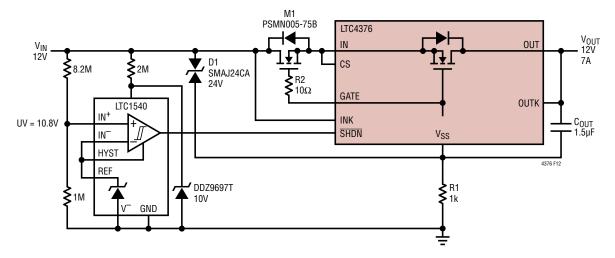


Figure 12. 12V Load Switch and Ideal Diode with Precise Undervoltage Lockout

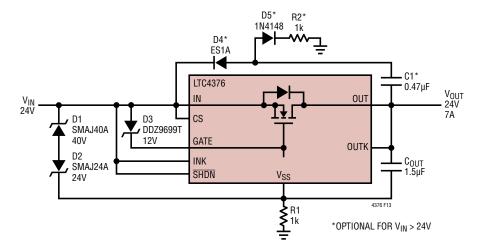


Figure 13. 24V/7A Ideal Diode with Reverse Input Protection to  $V_{\text{IN}} < V_{\text{OUT}} - 40V$ 

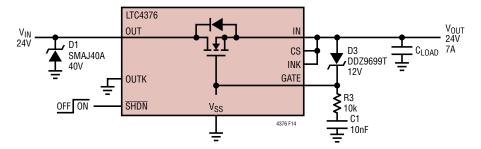


Figure 14. 24V Load Switch without Ideal Diode Function

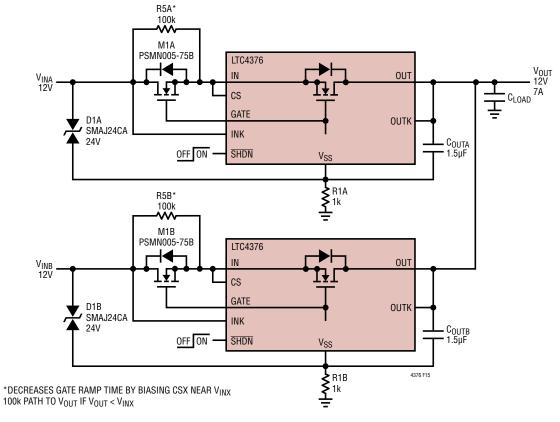


Figure 15. Diode-OR with Selectable Power Supply Feeds and Reverse Input Protection

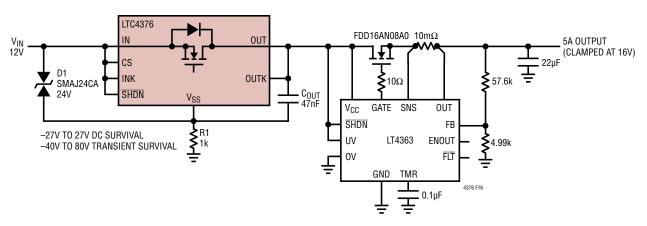
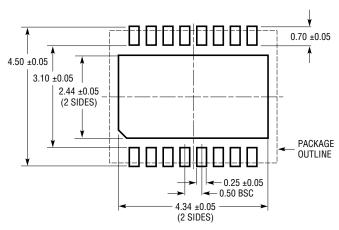


Figure 16. Overvoltage Protector and Ideal Diode Blocks Reverse Input Voltage

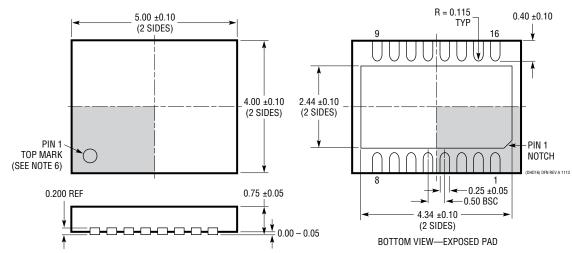
#### PACKAGE DESCRIPTION

## DHD Package 16-Lead Plastic DFN (5mm $\times$ 4mm)

(Reference LTC DWG # 05-08-1707 Rev A)



#### **RECOMMENDED** SOLDER PAD PITCH AND DIMENSIONS



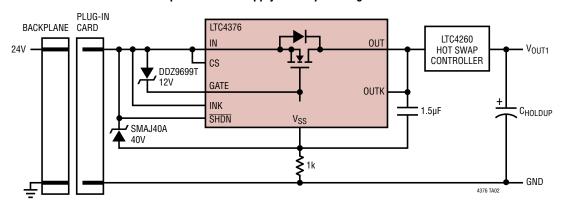
- NOTE
- 1. DRAWING PROPOSED TO BE MADE VARIATION OF VERSION (WJGD-2) IN JEDEC PACKAGE OUTLINE MO-229
- 2. DRAWING NOT TO SCALE
- 3. ALL DIMENSIONS ARE IN MILLIMETERS
- DIMENSIONS OF EXPOSED PAD ON BOTTOM OF PACKAGE DO NOT INCLUDE MOLD FLASH. MOLD FLASH, IF PRESENT, SHALL NOT EXCEED 0.15mm ON ANY SIDE
- 5. EXPOSED PAD SHALL BE SOLDER PLATED
- 6. SHADED AREA IS ONLY A REFERENCE FOR PIN 1 LOCATION ON THE TOP AND BOTTOM OF PACKAGE

## **REVISION HISTORY**

REV	DATE	DESCRIPTION	PAGE NUMBER
Α	08/19	Added AEC-Q100.	1, 2

## TYPICAL APPLICATION

#### Input Diode for Supply Hold-Up on Plug-In Card



## **RELATED PARTS**

PART Number	DESCRIPTION	COMMENTS
LT4256-1	High Voltage Hot Swap Controllers	Active Current Limiting, 10.8V to 80V Operation, Latch-Off/Auto-Retry
LTC4260	High Voltage Hot Swap Controller with I <sup>2</sup> C Compatible Monitoring	With I <sup>2</sup> C and ADC, Supplies from 8.5V to 80V
LTC4281	Hot Swap Controller with I <sup>2</sup> C Compatible Monitoring	With I <sup>2</sup> C and ADC, Supplies from 2.9V to 33V
LTC4352	Low Voltage Ideal Diode Controller	Controls N-Channel MOSFET, 0V to 18V Operation
LTC4353	Dual Low Voltage Ideal Diode Controller	Controls Two N-Channel MOSFETs, 0V to 18V Operation
LTC4355	High Voltage Ideal Diode-OR and Monitor	Controls Two N-Channel MOSFETs, 0.4µs Turn-Off, 80V Operation
LTC4357	High Voltage Ideal Diode Controller	Controls Single N-Channel MOSFET, 0.5µs Turn-Off, 80V Operation
LTC4358	5A Ideal Diode	Internal N-Channel MOSFET, 9V to 26.5V Operation
LTC4359	Ideal Diode Controller with Reverse Input Protection	Controls N-Channel MOSFET, 4V to 80V Operation, -40V Reverse Input
LT4363	High Voltage Surge Stopper with Current Limit	Stops High Voltage Surges, 4V to 80V, –60V Reverse Input Operation
LTC4364	Surge Stopper with Ideal Diode	4V to 80V Operation, -40V Reverse Input, -20V Reverse Output
LTC4371	Dual Negative Voltage Ideal Diode-OR Controller and Monitor	Controls Two MOSFETs, 220ns Turn-Off, Withstands > ±300V Transients
LTC4411	2.6A Ideal Diode	Internal N-Channel MOSFET, 2.6V to 5.5V Operation
LTC4415	4A Dual Ideal Diode	Internal P-Channel MOSFET, 1.7V to 5.5V Operation
LTC4413	2.6A Dual Ideal Diode	Internal P-Channel MOSFET, 2.5V to 5.5V Operation

## **X-ON Electronics**

Largest Supplier of Electrical and Electronic Components

Click to view similar products for Power Management IC Development Tools category:

Click to view products by Analog Devices manufacturer:

Other Similar products are found below:

EVAL-ADM1168LQEBZ EVB-EP5348UI MIC23451-AAAYFL EV MIC5281YMME EV DA9063-EVAL ADP122-3.3-EVALZ ADP1300.8-EVALZ ADP130-1.2-EVALZ ADP130-1.5-EVALZ ADP130-1.8-EVALZ ADP1714-3.3-EVALZ ADP1716-2.5-EVALZ ADP1740-1.5EVALZ ADP1752-1.5-EVALZ ADP1828LC-EVALZ ADP1870-0.3-EVALZ ADP1871-0.6-EVALZ ADP1873-0.6-EVALZ ADP1874-0.3EVALZ ADP1882-1.0-EVALZ ADP199CB-EVALZ ADP2102-1.25-EVALZ ADP2102-1.875EVALZ ADP2102-1.8-EVALZ ADP2102-2EVALZ ADP2102-3-EVALZ ADP2102-4-EVALZ ADP2106-1.8-EVALZ ADP2147CB-110EVALZ AS3606-DB BQ24010EVM
BQ24075TEVM BQ24155EVM BQ24157EVM-697 BQ24160EVM-742 BQ24296MEVM-655 BQ25010EVM BQ3055EVM

NCV891330PD50GEVB ISLUSBI2CKIT1Z LM2744EVAL LM2854EVAL LM3658SD-AEV/NOPB LM3658SDEV/NOPB LM3691TL1.8EV/NOPB LM4510SDEV/NOPB LM5033SD-EVAL LP38512TS-1.8EV EVAL-ADM1186-1MBZ EVAL-ADM1186-2MBZ